



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Marc Arques et al.
Serial No.: 10/716,692
Filing Date: November 19, 2003
Title: "PARTICLE DETECTOR AND A COUNTING DEVICE
COMPRISING A NUMBER OF PARTICLE
DETECTORS"
Docket No.: 36277

INFORMATION DISCLOSURE STATEMENT

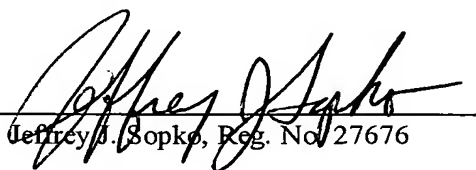
Commissioner for Patents
P.O. Box 1450
Alexandria, Va. 22313-1450

Sir/Madam:

In accordance with Rule 56, applicants are aware of the publications listed in the French Search Report (copy enclosed) and in the enclosed copy of Patent Office Form 1449. A copy of each of the publications is enclosed herewith.

Respectfully submitted,
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December 9, 2003

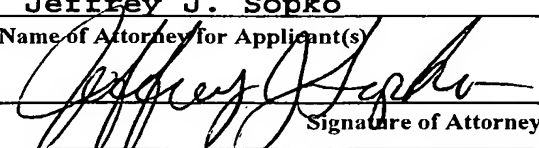
I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner of Patents, P.O. Box 1450, Alexandria, Va. 22313-1450 on the date indicated below.

Jeffrey J. Sopko

Name of Attorney for Applicant(s)

12/09/2003

Date


Signature of Attorney



Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 36277	SERIAL NO. 10/716,692
INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT: Marc Arques et al.	
		FILING DATE: November 19, 2003	GROUP ART UNIT:

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
	A	6,424,750 B1	07/2002	Colbeth et al.			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
	J						
	K						

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation
	L	1 102 323A1	05/2001	European			English Text
	M						
	N						
	P						
	Q						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	R	Patent Abstracts of Japan, Tomizaki Takayuki, "Image-Pickup Device", Publication No. 10285466, Publication Date October 23, 1998, 1 page
	S	
	T	

Examiner:

Date Considered

*Examiner: Initial if reference considered, regardless of whether citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.